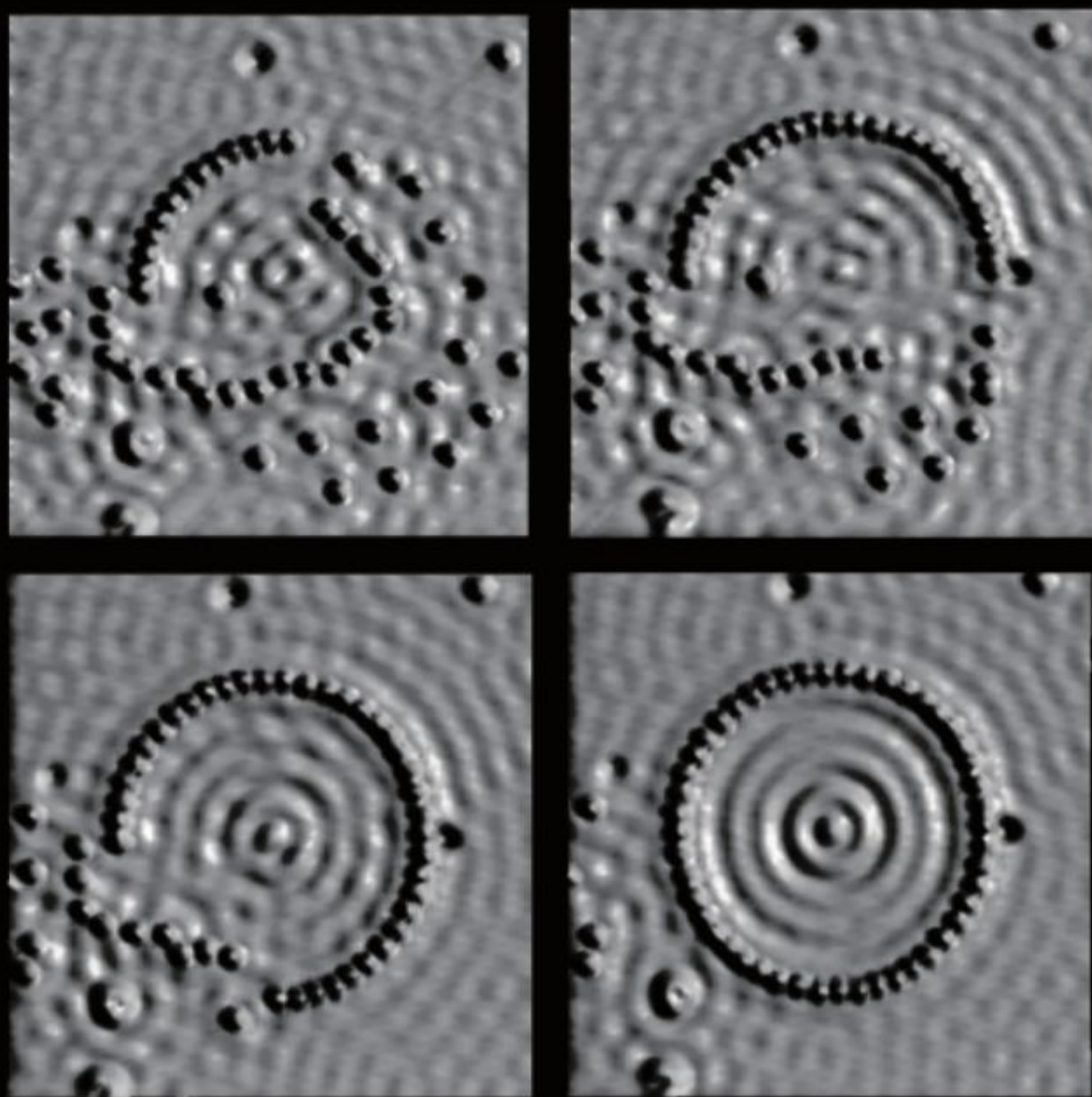




M. F. Crommie, C. P. Lutz, D. M. Eigler, IBM San José